

100V, N-CHANNEL

REPETITIVE AVALANCHE AND dv/dt RATED HEXFET® TRANSISTORS

Product Summary

Part Number	BVDSS	RDS(on)	I _D
IRLF120	100V	0.35Ω	5.3A



Description

The Logic Level 'L' series of power MOSFETs are designed to be operated with level logic gate-to-source voltage of 5V. In addition to the well established characteristics of HEXFETs [®], they have the added advantage of providing low drive requirements to interface power loads to logic level IC's and microprocessors.

Fields of applications include: high speed power applications such as switching regulators, switching converters, motor drivers, solenoid and relay drivers and drivers for high power bipolar switching transistors requiring high speed and low gate drive voltage.

The HEXFET technology is the key to International Rectifier's HiRel advanced line of logic level power MOSFET transistors. The efficient geometry and unique processing of the HEXFET achieve very low on-state resistance combined with high trans conductance and great device ruggedness.

Features

- Repetitive Avalanche Ratings
- Dynamic dv/dt Rating
- Low Drive Requirements
- Excellent Temperature Stability
- Fast Switching Speeds
- · Hermetically Sealed
- Light Weight
- ESD Rating: Class 1B per MIL-STD-750, Method 1020

Absolute Maximum Ratings

Symbol	Parameter	Value	Units	
I_{D1} @ V_{GS} = 5.0V, T_{C} = 25°C	Continuous Drain Current	5.3		
I _{D2} @ V _{GS} = 5.0V, T _C = 100°C	Continuous Drain Current	3.4	Α	
I _{DM} @ T _C = 25°C	Pulsed Drain Current ①	21		
P _D @T _C = 25°C	Maximum Power Dissipation	20	W	
	Linear Derating Factor	0.16	W/°C	
V_{GS}	Gate-to-Source Voltage	± 10	V	
E _{AS}	Single Pulse Avalanche Energy ②	120	mJ	
I _{AR}	Avalanche Current ①	5.3	Α	
E _{AR}	Repetitive Avalanche Energy ①	2.0	mJ	
dv/dt	Peak Diode Recovery dv/dt ③	5.5	V/ns	
T _J	Operating Junction and	-55 to + 150	°C	
T _{STG}	Storage Temperature Range	-55 to + 150		
	Lead Temperature	300 (0.063 in. /1.6 mm from case for 10s)		
	Weight	0.98 (Typical)	g	

For Footnotes, refer to the page 2.



Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	100			V	V _{GS} = 0V, I _D = 250μA
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.13		V/°C	Reference to 25°C, I _D = 250µA
	Static Drain-to-Source On-Resistance			0.35	Ω	V _{GS} = 5.0V, I _{D2} = 3.4A ④
$R_{DS(on)}$				0.42		V _{GS} = 4.0V, I _D = 2.7A ④
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Gfs	Forward Transconductance	3.1			S	V _{DS} = 15V, I _{D2} = 3.4A ④
I _{DSS}	Zero Gate Voltage Drain Current			250		$V_{DS} = 80V, V_{GS} = 0V$
	Zero Gate Voltage Drain Current			1000	μA	$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I_{GSS}	Gate-to-Source Leakage Forward			100	n 1	V _{GS} = 10V
	Gate-to-Source Leakage Reverse			-100	nA	V _{GS} = -10V
Q_G	Total Gate Charge			13		I _{D1} = 5.3A
Q_{GS}	Gate-to-Source Charge			2.4	nC	V _{DS} = 80V
Q_{GD}	Gate-to-Drain ('Miller') Charge			7.1		V _{GS} = 5.0V
$t_{d(on)}$	Turn-On Delay Time			13		V _{DD} = 50V
tr	Rise Time			73	20	I _{D1} = 5.3A
$t_{d(off)}$	Turn-Off Delay Time			41	ns	$R_G = 18\Omega$
t_f	Fall Time			27		V _{GS} = 5.0V
Ls +L _D	Total Inductance		7.0			Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm/ 0.25 in from package) with Source wire internally bonded from Source pin to Drain pin
C _{iss}	Input Capacitance		480			V _{GS} = 0V
C _{oss}	Output Capacitance		150		pF	V _{DS} = 25V
C_{rss}	Reverse Transfer Capacitance		30			f = 1.0MHz

Source-Drain Diode Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current (Body Diode)			5.3	^	
I _{SM}	Pulsed Source Current (Body Diode) ①			21	Α	
V _{SD}	Diode Forward Voltage			2.5	V	$T_J = 25^{\circ}C, I_S = 5.3A, V_{GS} = 0V$
t _{rr}	Reverse Recovery Time			220	ns	$T_J = 25^{\circ}C, I_F = 5.3A, V_{DD} \le 50V$
Q _{rr}	Reverse Recovery Charge			1.1	μC	di/dt = 100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Thermal Resistance

Symbol	Parameter	Min.	Тур.	Max.	Units	
$R_{ heta JC}$	Junction-to-Case			6.25	°CAM	
$R_{\theta JA}$	Junction-to-Ambient (Typical socket mount)			175	°C/W	

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- \odot V_{DD} = 25V, starting T_J = 25°C, L = 6.1mH, Peak I_L = 5.3A, V_{GS} = 5.0V, R_G = 25 Ω
- $\ \ \, 3$ $\ \ \, I_{SD} \leq 5.3A,\,di/dt \leq 110A/\mu s,\,V_{DD} \leq 100V,\,T_{J} \leq 150^{\circ}C,\,Suggested\,\,R_{G}$ =18 Ω
- 4 Pulse width $\leq 300 \ \mu s$; Duty Cycle $\leq 2\%$

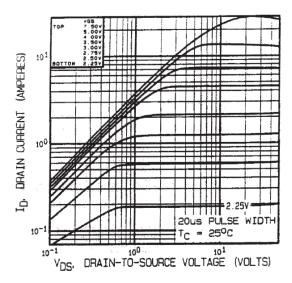


Fig 1. Typical Output Characteristics

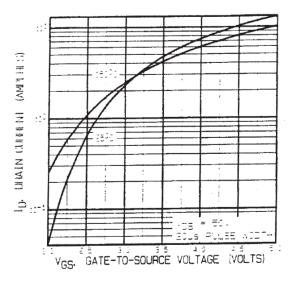


Fig 3. Typical Transfer Characteristics

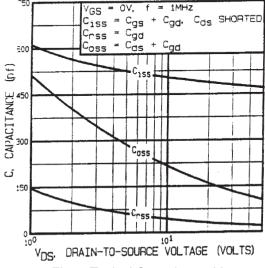


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

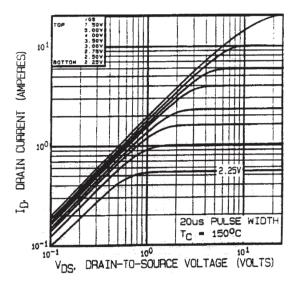


Fig 2. Typical Output Characteristics

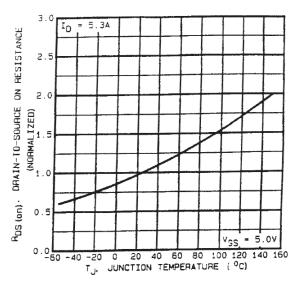


Fig 4. Normalized On-Resistance Vs. Temperature

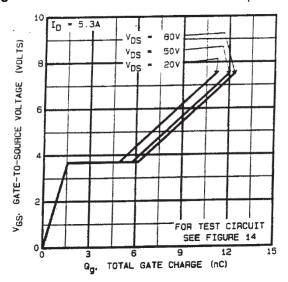


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

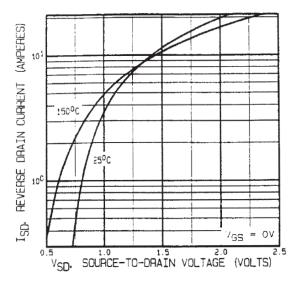


Fig 7. Typical Source-Drain Diode Forward Voltage

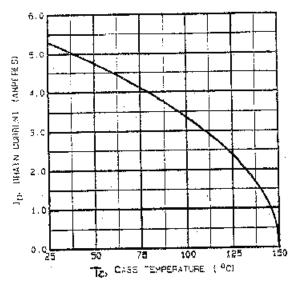


Fig 9. Maximum Drain Current Vs. Case Temperature

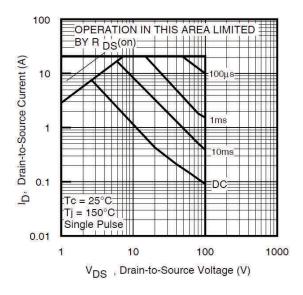


Fig 8. Maximum Safe Operating Area

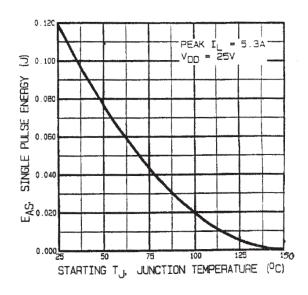


Fig 10. Maximum Avalanche Energy Vs. Drain Current

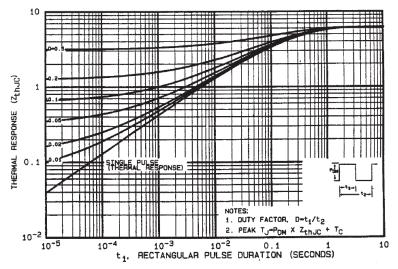


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



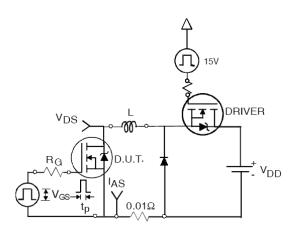


Fig 12a. Unclamped Inductive Test Circuit

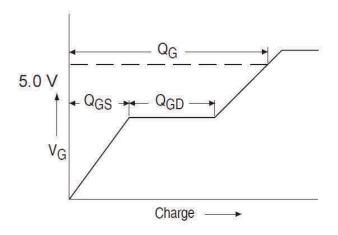


Fig 13a. Gate Charge Waveform

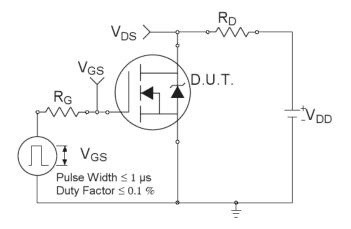


Fig 14a. Switching Time Test Circuit

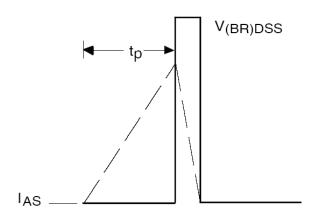


Fig 12b. Unclamped Inductive Waveforms

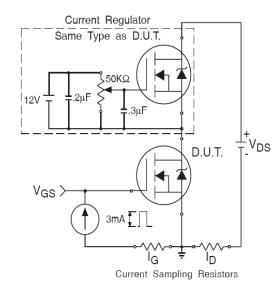


Fig 13b. Gate Charge Test Circuit

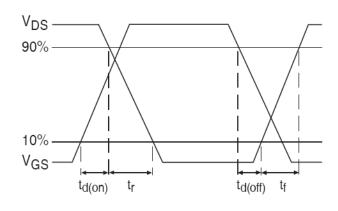
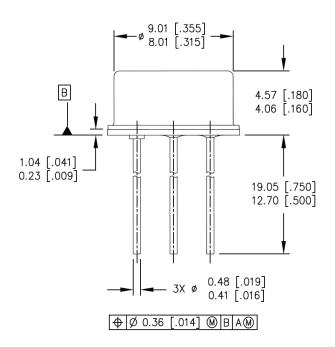


Fig 14b. Switching Time Waveforms

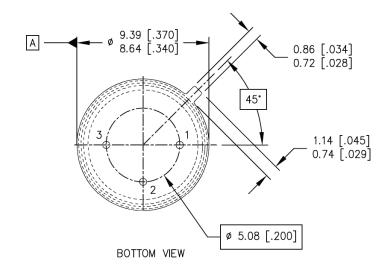


Case Outline and Dimensions - TO-205AF (TO-39)



NOTES: SIDE VIEW

- 1. DIMENSIONING AND TOLERANCING PER ASME 14.5M-1994.
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. CONTROLLING DIMENSION: INCH.
- 4. CONFORMS TO JEDEC OUTLINE TO-205AF (TO-39).



LEGEND

- 1- SOURCE
- 2- GATE
- 3- DRAIN (CONNECTED TO THE CASE)



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